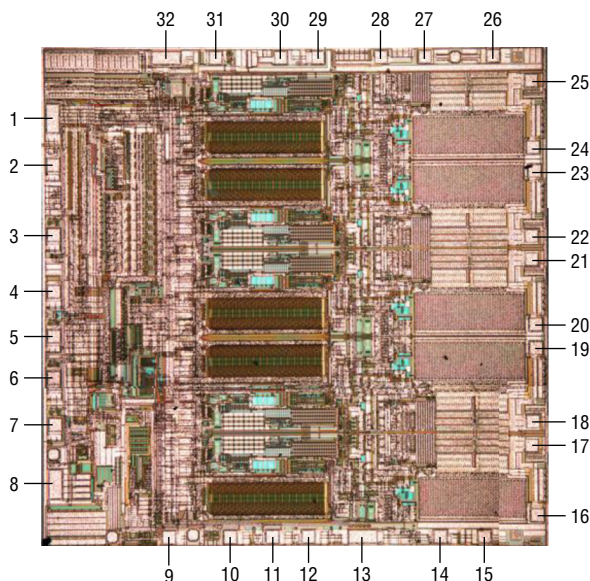


LTC2662-16

5-Channel, 300mA Current-Source-Output 16-Bit SoftSpan™ DACs

PAD FUNCTION

DIE CROSS REFERENCE



140mils × 138mils
Backside metal: None
Backside potential: GND

1. GND	17. V _{DD4}
2. TGP	18. V _{DD3}
3. SDI	19. OUT3
4. SDO	20. OUT2
5. SCK	21. V _{DD2}
6. \overline{CS}/LD	22. V _{DD1}
7. \overline{LDAC}	23. OUT1
8. GND	24. OUT0
9. REFLO	25. V _{DD0}
10. REF	26. V ⁻
11. REFCOMP	27. V ⁺
12. FSADJ	28. MUX
13. V _{CC}	29. IOV _{CC}
14. GND	30. \overline{FAULT}
15. V ⁻	31. CLR
16. OUT4	32. GND

LTC Finished Part Number	Order Part Number
LTC2662-16	LTC2662-16DWF#6AJ LTC2662-16DICE#6AJ

Please refer to [LTC2662-16](#) standard product data sheet for other applicable product information.

*DWF = DICE in wafer form.

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DICE/DWF ELECTRICAL TEST LIMITS

T_J = 25°C. V_{CC} = IOV_{CC} = 5V; V⁻ = -5V; V_{DD0-4} = 5V; V⁺ = 5V;

FSADJ = V_{CC}; V_{REF} = 1.25V External, unless otherwise noted.

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
DC Performance All Ranges (Note 2)						
	Resolution		16			Bits
	Monotonicity	(Note 1)	16			Bits
DNL	Differential Nonlinearity	(Note 1)		±0.2	±1	LSB
INL	Integral Nonlinearity	(Note 1)		±12	±64	LSB
IOS	Offset Error Current	(Note 1)		±0.1	±0.4	%FSR
GE	Gain Error (Note 2)	300mA, 200mA, 100mA Ranges		0.3	0.9	%FSR
		50mA, 25mA Ranges		0.4	1.2	%FSR
		12.5mA, 6.25mA, 3.125mA Ranges		0.7	1.5	%FSR
TUE	Total Unadjusted Error (Note 2)	300mA, 200mA, 100mA Ranges		0.4	1.4	%FSR
		50mA, 25mA Ranges		0.5	1.7	%FSR
		12.5mA, 6.25mA, 3.125mA Ranges		0.8	2	%FSR
DC Performance						
V _{DROPOUT}	Dropout Voltage (V _{DDX} – V _{OUTX}) (Notes 2, 3)	I _{OUTX} ≤ 200mA, (V _{DDX} – V ⁻) = 4.75V		0.7	1	V
	Hi-Z Output Leakage Current	I _{OUTX} = Hi-Z, (V _{DDX} – V ⁻) = 4.75V		0.1	1	μA
R _{PULL-DOWN}	OUTX Pull-Down Switch Resistance to V ⁻ Supply	Span Code = 1000b, Sinking 50mA		8	12	Ω
Reference						
V _{REF}	Reference Output Voltage	Internal Reference	1.248	1.25	1.252	V

Rev. A

DICE/DWF SPECIFICATION

LTC2662-16

DICE/DWF ELECTRICAL TEST LIMITS

FSADJ = V_{CC} , V_{REF} = 1.25V External, unless otherwise noted.

$T_J = 25^\circ\text{C}$. $V_{CC} = IOV_{CC} = 5V$; $V^- = -5V$; $V_{DD0-4} = 5V$; $V^+ = 5V$;

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
Power Supply						
V_{CC}	Analog Supply Voltage	V_{CC} Must Not Exceed V^+	2.85		5.5	V
IOV_{CC}	Digital I/O Supply Voltage		1.71		V_{CC}	V
V^-	Negative Supply Voltage		-15.75		0	V
V^+	Positive Supply Voltage		2.85		$V^- + 33$	V
V_{DD0} to V_{DD4}	Output Supply Voltages		2.85		V^+	V
	Supply Current V_{CC}	All Ranges (Code = 0, All Channels)		2.6	3.8	mA
	Supply Current IOV_{CC}	All Ranges (Code = 0, All Channels)		0.01	2	μA
	Supply Current V^+	All Ranges (Code = 0, All Channels)		385	500	μA
	Supply Current V^-	All Ranges (Code = 0, All Channels)		2.3	3.2	mA
	Supply Current V_{DD0-4}	All Ranges (Code = 0, per Channel)		0.7	1.2	mA
I_{SLEEP}	Shutdown Current V_{CC}	(Note 4)		1	10	μA
	Shutdown Current IOV_{CC}	(Note 4)		0.01	2	μA
	Shutdown Current V^+	(Note 4)		20	45	μA
	Shutdown Current V^-	(Note 4)		30	65	μA
	Shutdown Current V_{DD0-4}	(Note 4) per Channel		4.2	8.1	μA

Note 1: Linearity is defined from code 384 to code 65,535. Offset current is measured at code 384.

Note 2: Wafer probe testing is performed at output currents of up to 100mA. Output currents over 100mA are guaranteed by design and characterization.

Note 3: Test conditions: 200mA range; $I_{OUTX} = 100\text{mA}$.

Note 4: Digital Inputs at 0V or IOV_{CC} .

Wafer level testing is performed per the indicated specifications for dice. Considerable differences in performance can often be observed for dice versus packaged units due to the influences of packaging and assembly on certain devices and/or parameters. Please consult factory for more information on dice performance and lot qualifications via lot sampling test procedures.

Dice data sheet subject to change. Please consult factory for current revision in production.

I.D.No. 66-13-226816

Rev. A

Mouser Electronics

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